

COINCIDENCE STUDY OF DOUBLE ELECTRON EMISSION ASSOCIATED WITH K-SHELL PHOTOIONIZATION OF C₆₀

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Abstract:

The (multiple) photoionization and subsequent fragmentation of the C₆₀ molecule was studied with the synchrotron radiation after removing electrons from the inner K-shell. Our intention was especially focused on the dynamics of the subsequent fragmentation. In addition to 'normal' (non-coincident) electron and ion time-of-flight spectroscopy, we investigated this topic with the help of an electron-electron-coincidence measurement. Our experiment shows that in these processes C₆₀^{q+} ions with charge states up to 3+ and several smaller C_{60-2m}^{q+} fragments are formed. In addition, the broad peak besides the C(1s) line, usually referred to as the 'plasmon' peak, has been observed.

Key words: molecular physics, photoelectron-photoion spectroscopy, plasmon excitation.

Introduction

Since the discovery of C₆₀ molecule (Kroto et al, 1985, pp.162-163), (Krätschmer et al, 1990, pp.354-358) many studies were performed to investigate its fundamental properties. Due to its high symmetry, C₆₀

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represents an ideal cluster with many possible applications. Its properties are mainly driven by its unique molecular structure like a spherical shell (Kusmany et al, 1993), (Korica et al, 2005, pp.132031-132035). So far, only a little is known about the C₆₀ fragmentation after K-shell ionization (Aksela et al, 1995, pp.2112-2115), (Karvonen et al, 1997, pp.3466-3472), (Leiro et al, 2003, pp.205-213). For the main fragmentation channel, the (successive) emission of neutral C₂ has been proposed for a low charge state (Scheier et al, 1994, pp.77–93), although the emission of other neutral carbon atoms/small clusters is also present (Lykke, 1995, pp.1354–1357). Even triply charged fullerene ions appear to be rather stable (Bernard et al, 2003, pp.196–200). Highly charged C₆₀ ions often decay through *fission* processes leading to a multiply charged fullerene and at least one other charged carbon atom or cluster, or they undergo *multi-fragmentation* processes leading exclusively to small, charged and neutral carbon clusters (Reinköster et al, 2003, pp.263–267).

Experiment

The measurements were performed at the HASYLAB undulator beam line BW3 in Hamburg and at the BESSYII dipole beamline TGM4 in Berlin using monochromatized synchrotron radiation whose wavelength can be scanned with a resolution set to an appropriate value. Measurements of Ne/Ar-resonances were carried out to check the accuracy of the monochromator settings. The photon beam crosses an effusive beam of C₆₀ molecules, provided by an oven heated to 500 °C. Outgoing electrons are detected in time-of-flight (TOF) electron spectrometers at two different angles with respect to the electric vector of the ionizing radiation (Fig1.(a)). Appropriate voltages can be applied to the TOF-analysers to keep a constant resolution of the electron spectra for different photon energies. Some measurements were recorded in the coincidence mode. Additional fullerene ion data were accumulated using a multi-hit capable ion spectrometer with a pulsed electrical separation field (Fig.1(b)). The positively charged C₆₀ ions or fragments are separated according to their mass-per-charge ratio by a pulsed field (pulse amplitude = 820 V, duration = 10 µs, repetition rate = 12 kHz, rise time < 15 ns, field length = 5 mm). The ions are accelerated into a potential of -2800 V (field length = 4 mm) followed by a 200 mm long field-free drift tube. After passing the drift tube, the ions hit the detector surface which is held at a constant voltage of -3300 V. The distance from the drift tube to the detector is 5 mm. The detector consists of a Z-stack of MCPs with an active diameter of 40 mm.

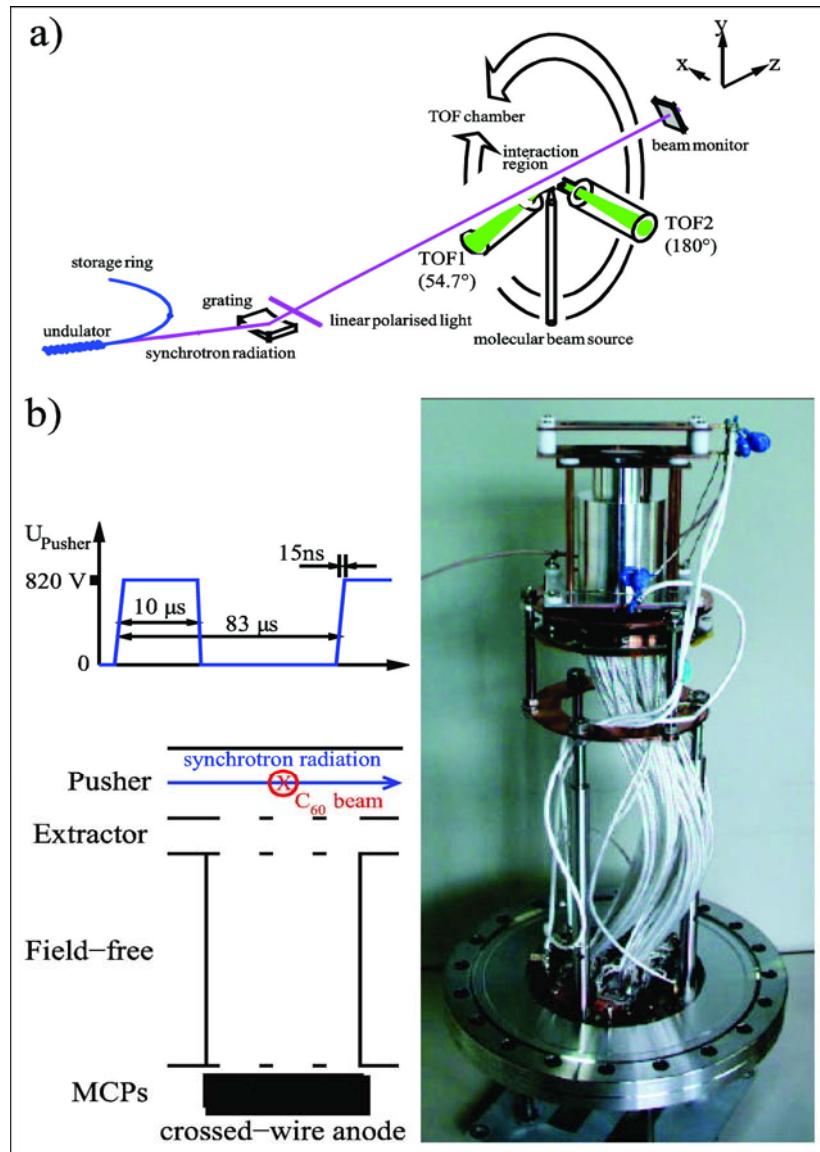


Figure 1 – Sketch of the experimental set-up. (a) beam source with the electron time-of-flight (TOF) spectrometer. (b)schematic view and picture of the ion spectrometer

Рис. 1 – Изображение экспериментального устройства (а) источник света с TOF спектрометром. (б) ионный спектрометр

Слика 1 – Приказ експерименталног уређаја: (а) извор снопа са TOF спектрометром, (б) јонски спектрометар

Results and discussion

Inner shell ionization and fragmentation of C₆₀ molecule

Figure 2 shows an example of the ion spectrum recorded at the photon energy of 390 eV. The inset shows the low-mass region of the spectrum. A rough classification of different processes is indicated by different coloured areas. In these processes, C_{60-2m}²⁺ ions with charge states up to 3+ and several smaller C_{60-2m}^{q+} fragments have been observed. This is in accordance with the previous claim that the main fragmentation channel is the emission of neutral C₂. Large singly charged carbon clusters (such as C₃₀⁺, C₂₉⁺, or C₂₀⁺) have no particular stability and one ought to expect additional species with similar sizes (such as C₃₁⁺ or C₂₁⁺), which have not been observed. For all photon energies used, no small charged carbon fragments resulting from fission or multi-fragmentation processes are observed.

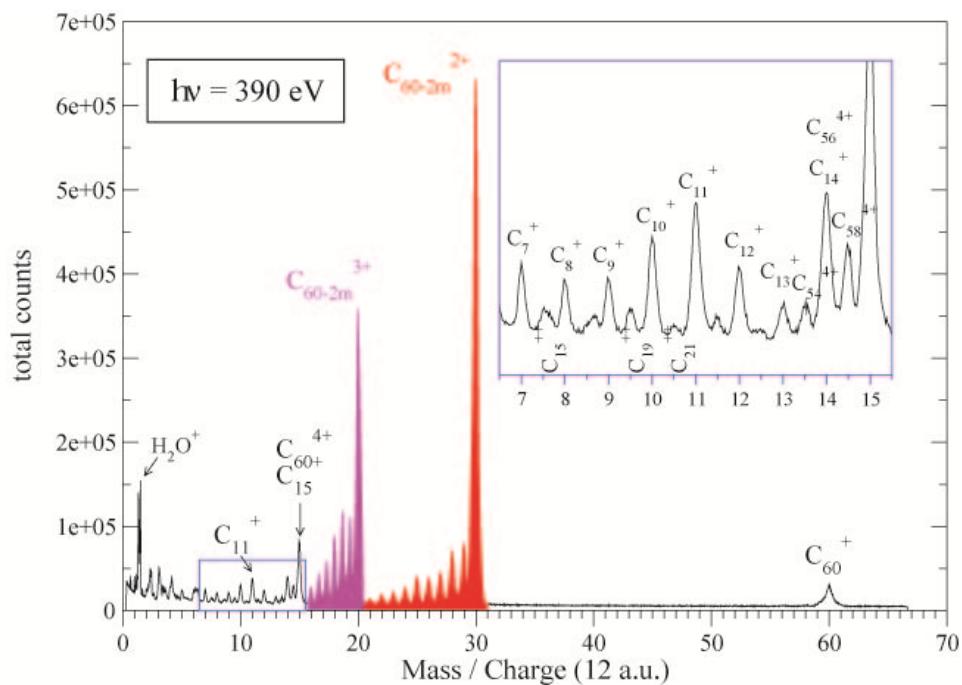


Figure 2 – Ion spectrum recorded with a photon energy of 390 eV

Рис. 2 – Ионный спектр, записанный на энергии фотона 390 еВ

Слика 2 – Јонски спектар снимљен на енергији фотона од 390 еВ

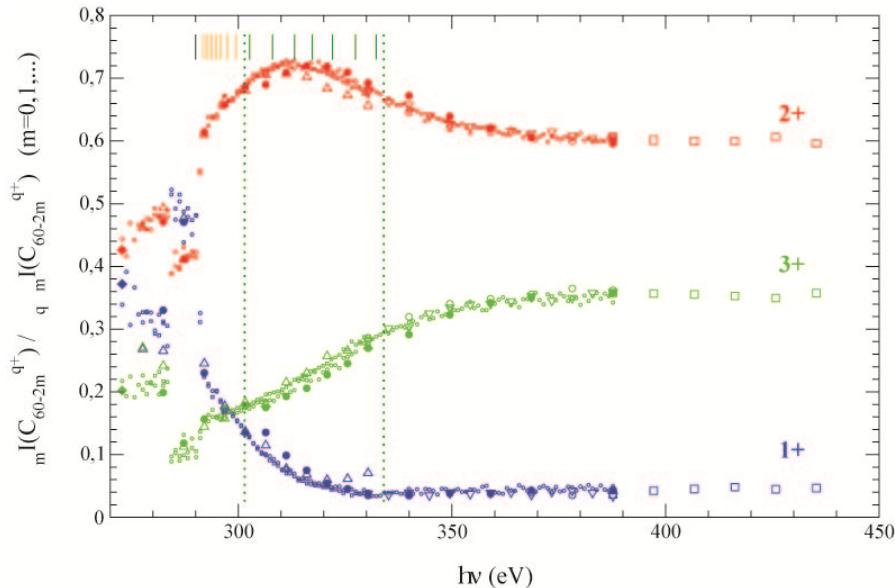


Figure 3 – Contributions of singly, doubly, and triply charged fullerene ions for several photon energies. Different scans are marked by different symbols. The results of the coincident electron spectrum are marked by 'e'. The vertical lines indicate the C(1s) threshold (Δ), electron shake-up levels (Δ), and plasmon excitation energies (Δ) (Leiro et al, 2003, pp. 205-213). The high amount of triply charged fullerenes can be explained by double Auger and electron shake-off processes, observed in the electron-electron-coincidence map (Fig. 4).

Рис. 3 – Вклад однозарядных, двухзарядных и трехзарядных ионов фуллерена по некоторым значениям энергии фотона. Разные сканы отмечены различными символами. Результаты совпадающего электронного спектра обозначены «е». Вертикальные линии обозначают C (1s) порог (Δ), электронные уровни sheik-up (Δ) и энергию возбуждения плазмы (Δ) (Leiro et al, 2003, pp. 205-213). Высокий процент трехзарядных фуллеренов можно объяснить двойными Оже-процессом и электронным sheik-up процессом, которые видны на карте совпадений электронов (рис. 4).

Слика 3 – Доприноси једноструко, двострукто и трострукто наелектрисаних јона фуллерена за неколико вредности енергије фотона. Различити скенови су означени различитим симболима. Резултати коинцидентног електронског спектра означени су са 'е'. Вертикалне линије означавају C (1s) границу (Δ), електронске шејк-ап нивое (Δ) и енергије плазмонских ексцитација (Δ) (Leiro et al, 2003, pp. 205-213). Висок проценат трострукто наелектрисаних фуллерена може се објаснити двоструким Ожеовим и електронским шејк-оф процесима, који се могу видети на електрон-електрон коинцидентној мапи (слика 4).

Figure 3 shows contributions of singly, doubly and triply charged fullerene ions for several photon energies. These results indicate that, above the carbon K-shell of C₆₀, the main products are doubly and triply charged fullerenes. C⁺₆₀ is the most abundant ion in the low energy region. The relative C²⁺₆₀ yield compared to the C⁺₆₀ yield first increases with increasing photon energy and stagnates above ≈350 eV at a nearly constant level. The yield of triply charged C³⁺₆₀ is similar to the yield of C²⁺₅₈. Different doubly charged C²⁺_{60-2m} fragments appear step by step with increasing photon energy. The yields of singly charged fragments exhibit an enhancement in certain photon energy regions; at high photon energies, these yields decrease and are only slightly visible.

So the obtained ion yield spectroscopy of gas phase C₆₀ is corroborated by the corresponding photoelectron measurements (Korica et al, 2018). The continuous intensity distribution in the photoelectron spectra can be either the result of direct double photoionization or double-Auger decay. The quality of the former K-shell photoelectron measurements was insufficient to disentangle these two contributions experimentally (Aksela et al, 1995, pp.2112-2115), (LeBrun et al, 1994, pp.3965-3968), (Brühwiler et al, 1993, pp.3721-3724), (Krummacher et al, 1993, pp.8424-8429). In general, the disentanglement of the two processes on the basis of normal ion or electron spectroscopy is not unambiguously possible.

Electron-electron coincidence spectroscopy of excited C₆₀

Electron-electron-coincidence measurements were carried out to get a deeper understanding about the fundamental processes causing the many-electron emission in C₆₀. Here, a separation of different underlying processes can be better achieved. (Fig. 4).

Shake-off electrons are abundant at low-kinetic energies. Therefore, even at such high photon energies, shake-off processes are important to understand the yields of the multiply charged C₆₀ ions besides the Auger and double Auger processes. In the case that two shake-off electrons leave the C₆₀ molecule, the energy sharing is very asymmetric. The faster of the two shake-off electrons contributes significantly to the broad peak besides the C(1s) main line, usually referred to as the 'plasmon' peak (Hertel et al, 1992, pp.784-787), (Leiro et al, 2003, pp.205-213); this possibility has been unrevealed so far.

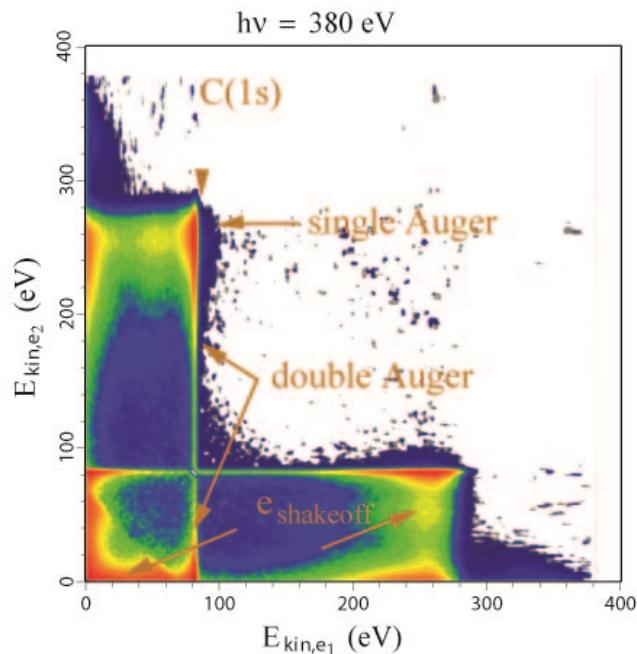


Figure 4 – Electron-electron coincidences as a function of the kinetic energy of the two detected electrons. The coincidence map was recorded with a photon energy of 380 eV.

*Рис. 4 – Карта совпадений электронов как функция кинетической энергии двух обнаруженных электронов. Карта совпадений записана на энергии фотона 380 еВ.
Слика 4 – Електрон-електрон коинциденце као функција кинетичке енергије два детектирана електрона. Коинцидентна мапа снимљена је на енергији фотона од 380 еВ.*

Conclusion

We have studied the photoionization of the C_{60} molecule above the C(1s) threshold, in the photon energy range $h\nu=(330-390)$ eV. A careful analysis of the spectra yielded a surprising and unexpected result.

Clear hints have been found that the major contribution to the triply charged ion yield is the direct double photoionization of C_{60} . However, in contrast to most atoms and molecules, it is driven by the plasmon excitation associated with the K-shell photoionization of the fullerenes. Whereas the K-shell satellites are still bound core excited ionic states of the C_{60} molecule, plasmon excitations at higher binding energies are already in the double electron emission continuum. This causes a specific intensity distribution and explains the origin of the broad resonance features in the continuum part of the spectrum and an unusual high amount of triply charged fullerenes of 40%.

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ИССЛЕДОВАНИЕ ДВОЙНОЙ ЭЛЕКТРОННОЙ ЭМИССИИ, СВЯЗАННОЙ С ФОТОИОНИЗАЦИЕЙ К-ОБОЛОЧКИ C₆₀

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ОБЛАСТЬ: молекуларная физика, фотоэлектрон-фотоионная спектроскопия

ВИД СТАТЬИ: оригинальная научная статья

ЯЗЫК СТАТЬИ: английский

Резюме:

(Многогранная) фотоионизация и сопроводительная фрагментация молекулы C₆₀ исследовалась с помощью синхротронного излучения после выброса электрона из

внутренней К-оболочки. Наше исследование было сосредоточено на динамике сопроводительной фрагментации. Кроме «нормальной» (несовпадающей) электронной и ионной спектроскопии, применялись и другие методы измерений, так например, было проведено измерение электронного совпадения. Наш эксперимент показал, что в течение этих процессов формируются C^{q+}₆₀ ионы с зарядом до трех + и несколько небольших C^{q+}_{60-2m} фрагментов. Кроме того, был выявлен широкий пик рядом с основной линией С (1s), так называемым «плазмоном».

Ключевые слова: молекулярная физика, фотоелектронно-фотоионная спектроскопия, возбуждение плазона.

КОИНЦИДЕНТНА СТУДИЈА ДВОСТРУКЕ ЕЛЕКТРОНСКЕ ЕМИСИЈЕ ПОВЕЗАНЕ СА ФОТОЈОНИЗАЦИЈОМ К-ЉУСКЕ C₆₀

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ОБЛАСТ молекуларна физика, фотоелектронско-фотоионска спектроскопија

ВРСТА ЧЛАНКА: оригинални научни чланак
ЈЕЗИК ЧЛАНКА: енглески

Сажетак:

Фотојонизација (вишеструка) и пратећа фрагментација молекула C₆₀ проучавана је уз помоћ синхротронског зрачења након избацања електрона из унутрашње К-љуске. Наше истраживање било је посебно фокусирано на динамику пратеће фрагментације. Поред „нормалне“ (некоинцидентне) електронске и јонске ТОФ спектроскопије, ову тему изучавали смо и уз помоћ електрон-електрон коинцидентног мерења. Наш експеримент показује да се у овим процесима формирају C^{q+}₆₀ јоњи са наелектрисањем до 3+ и неколико мањих C^{q+}_{60-2m} фрагмената. Поред тога, поред главне C(1s) линије уочен је широки пик, тзв. плазмон.

Кључне речи: физика молекула, фотоелектронска-фотоионска спектроскопија, плазмонска ексцитација.

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